

# Sizing Current Transformers for Line Protection Applications

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# Outline

- CT basics
- Effects of CT saturation on protection elements
- Advances in modern protection designs
- Tools for CT sizing



# CT Basics

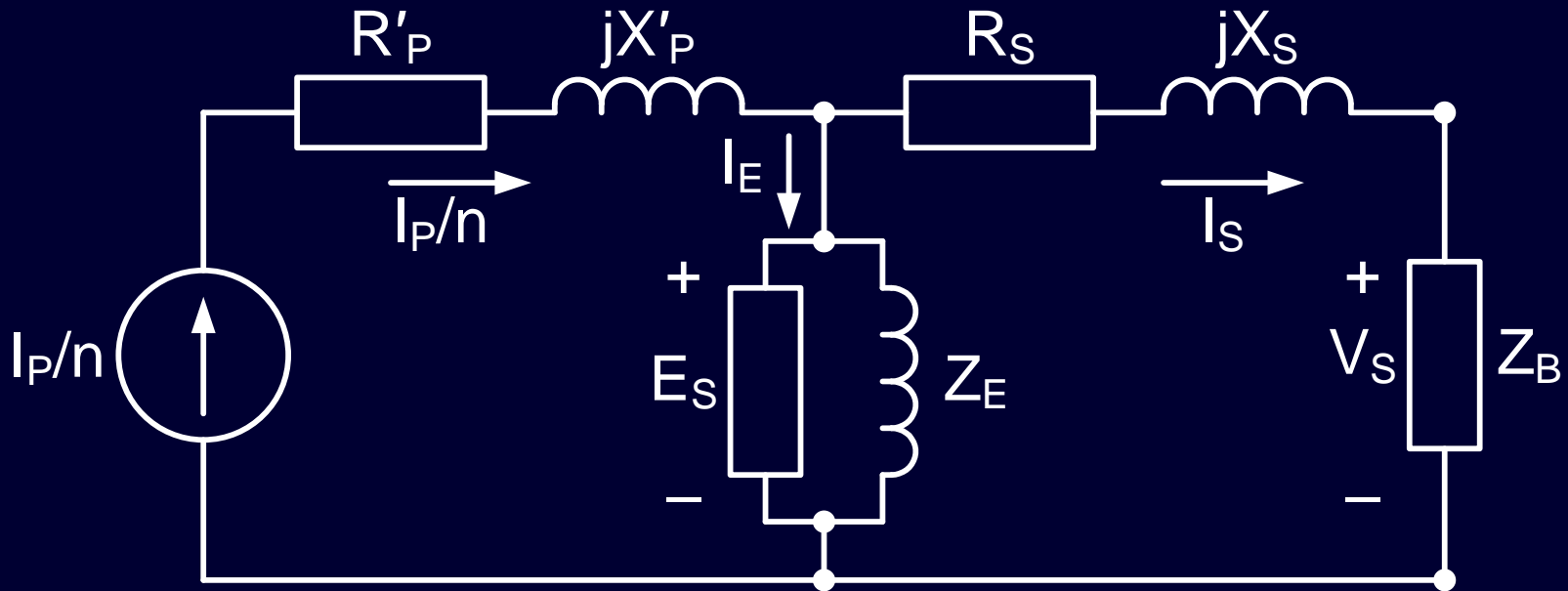
# Ideal CT Behavior

$$I_P n_P = I_S n_S$$

$$I_S = \frac{n_P}{n_S} I_P = \frac{I_P}{n_S / n_P} = \frac{I_P}{n}$$

$$I_S(\text{pu}) = I_P(\text{pu})$$

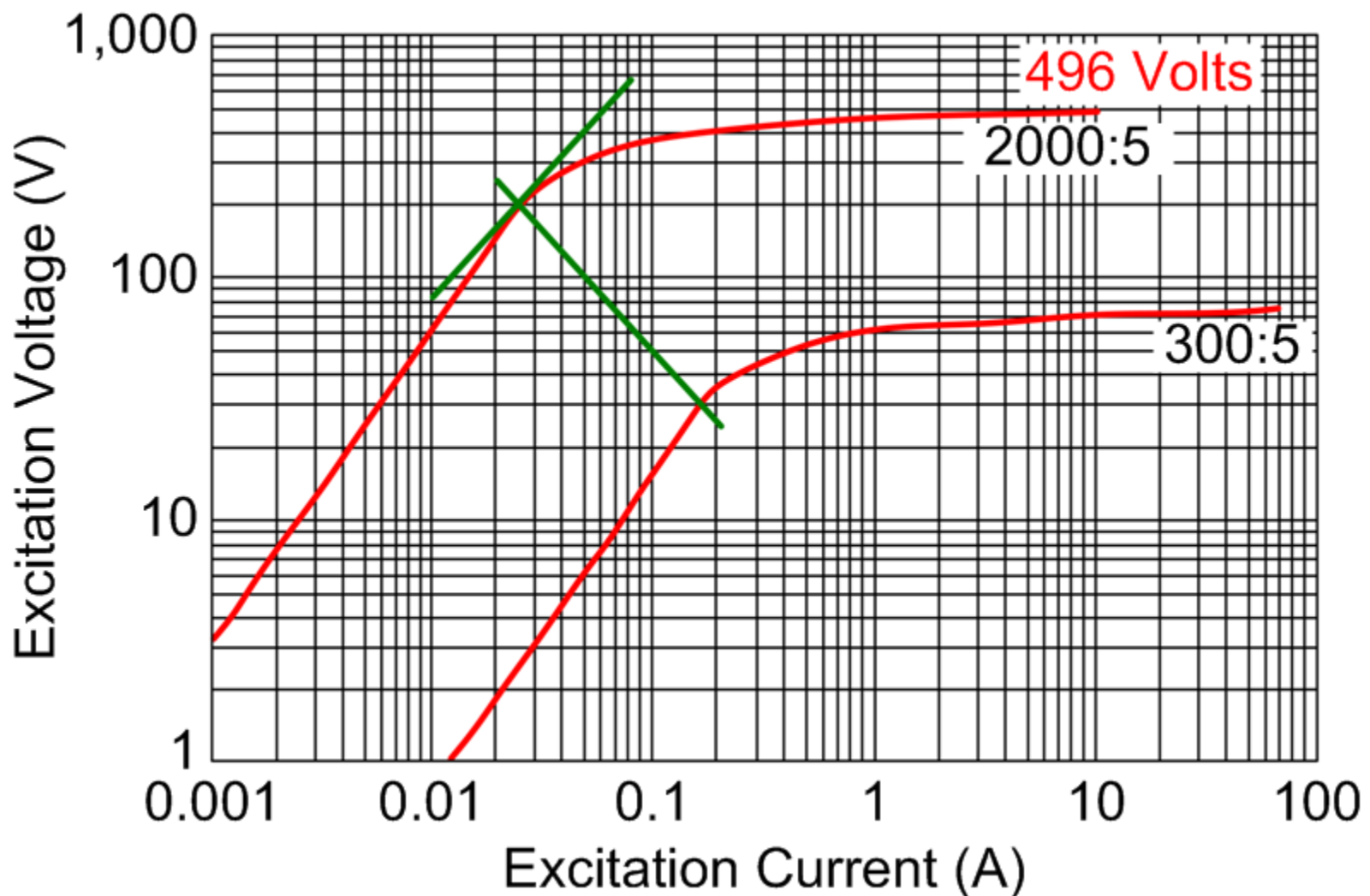
# Real CT Behavior



$$I_S = \frac{I_P}{n} - I_E$$

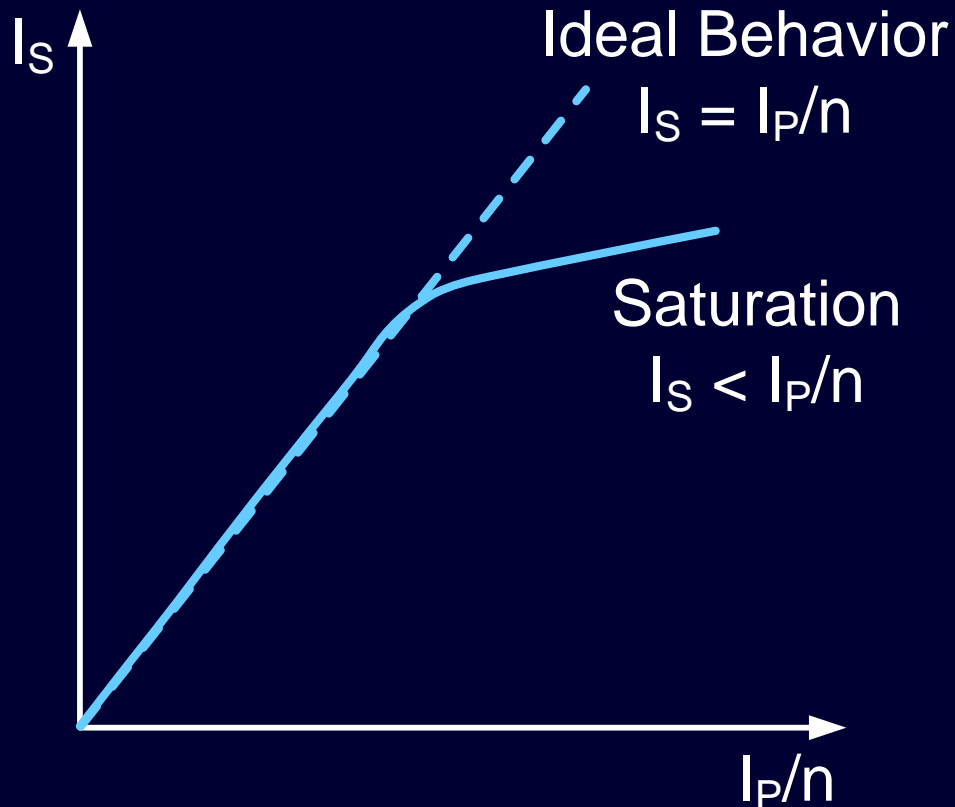
$$V_S = I_S Z_B = E_S - I_S (R_S + jX_S)$$

# Typical Excitation Characteristic for Multiratio CT

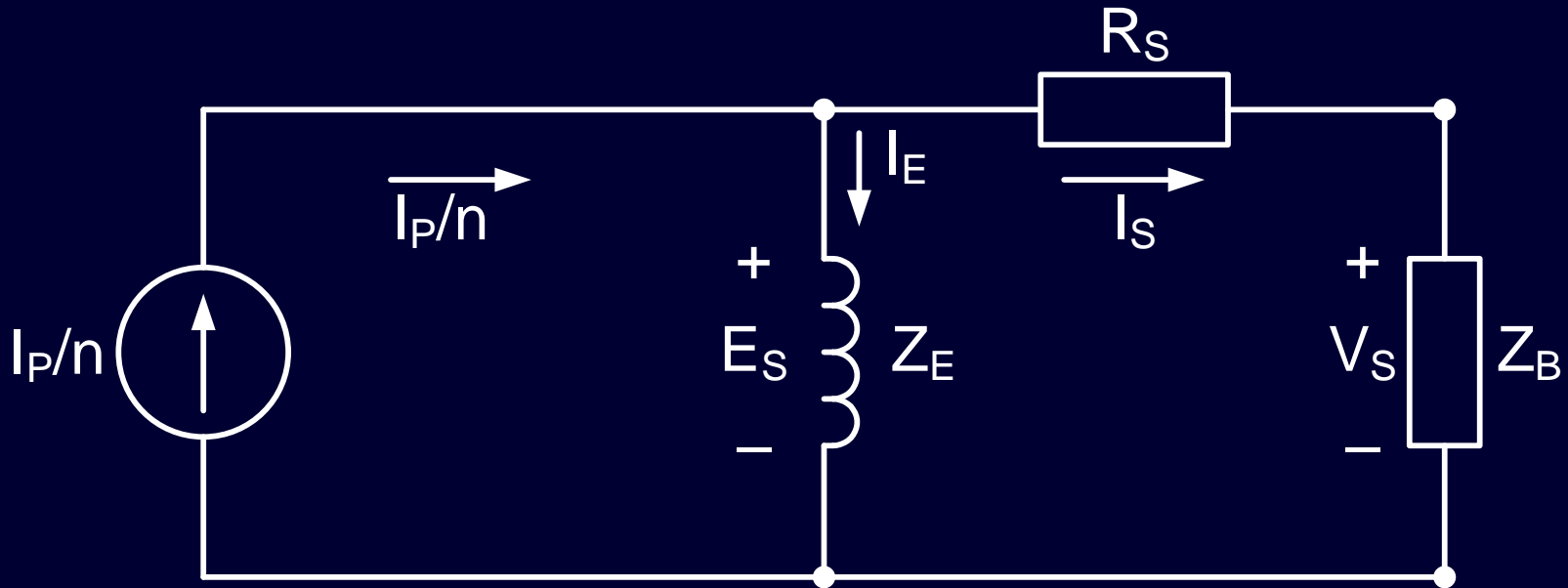


# CT Errors

$$\text{Ratio error (\%)} = \frac{I_E}{I_S} \cdot 100$$



# Class C and Class K CT Equivalent Circuit



$$V_{STD} = 20 I_{S\text{ RATED}} Z_{B\text{ STD}}$$



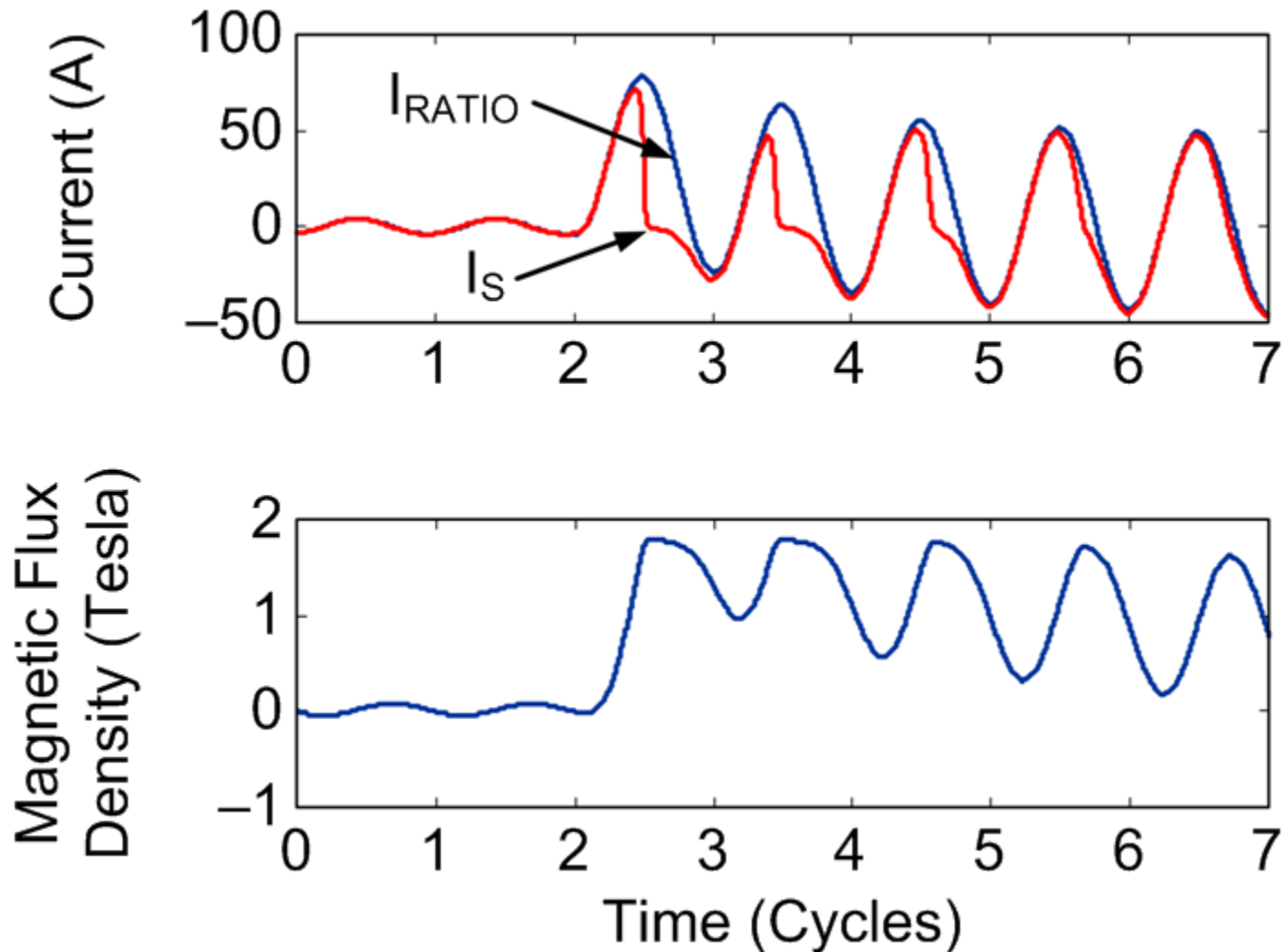
# Avoiding CT Saturation for Symmetrical Currents

$$V_S \leq V_{STD}$$

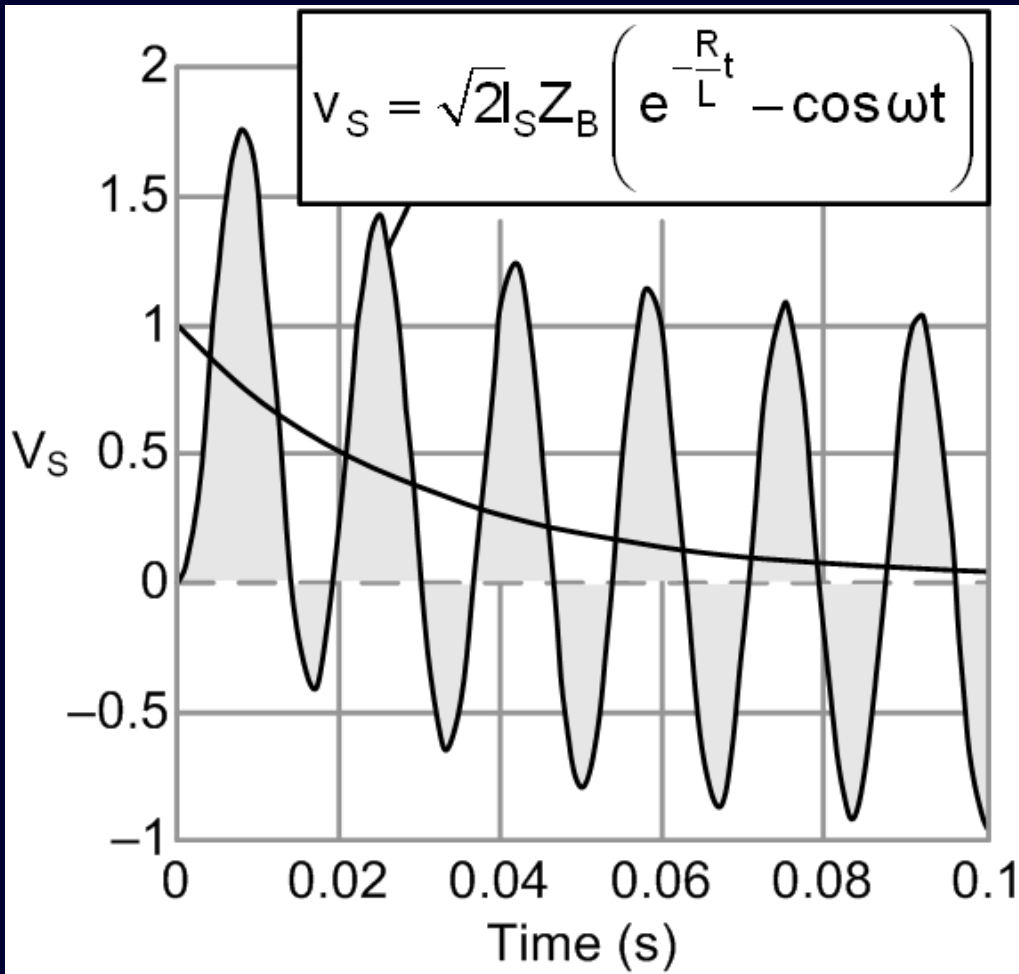
$$\frac{I_S}{I_{S \text{ RATED}}} \cdot \frac{Z_B}{Z_{B \text{ STD}}} \leq 20$$

$$I_f Z_b \leq 20$$

# CT Transient Operation



# Avoiding CT Saturation for Offset Currents

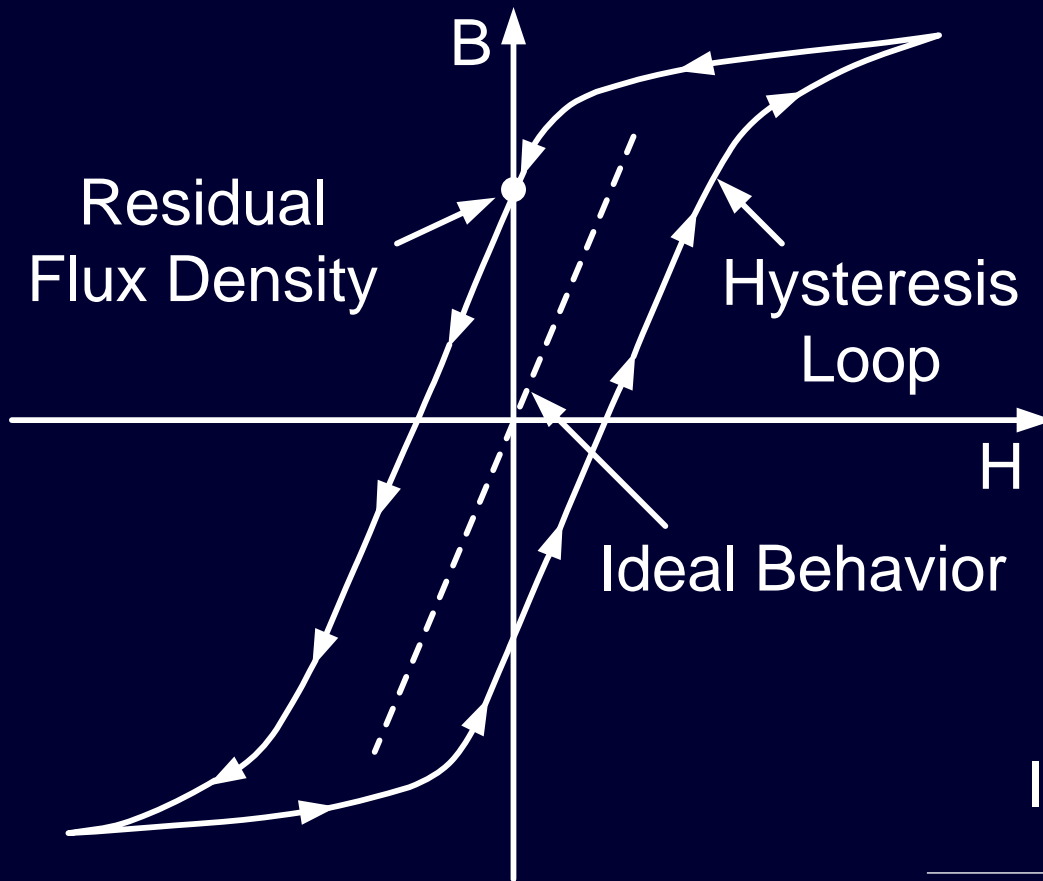


$$V_S = n_s B A I_S Z_B \left( \frac{X}{R} + 1 \right)$$

$$\frac{I_S}{I_{S \text{ RATED}}} \cdot \frac{Z_B}{Z_{B \text{ STD}}} \left( \frac{X}{R} + 1 \right) \leq 20$$

$$I_f Z_b \left( \frac{X}{R} + 1 \right) \leq 20$$

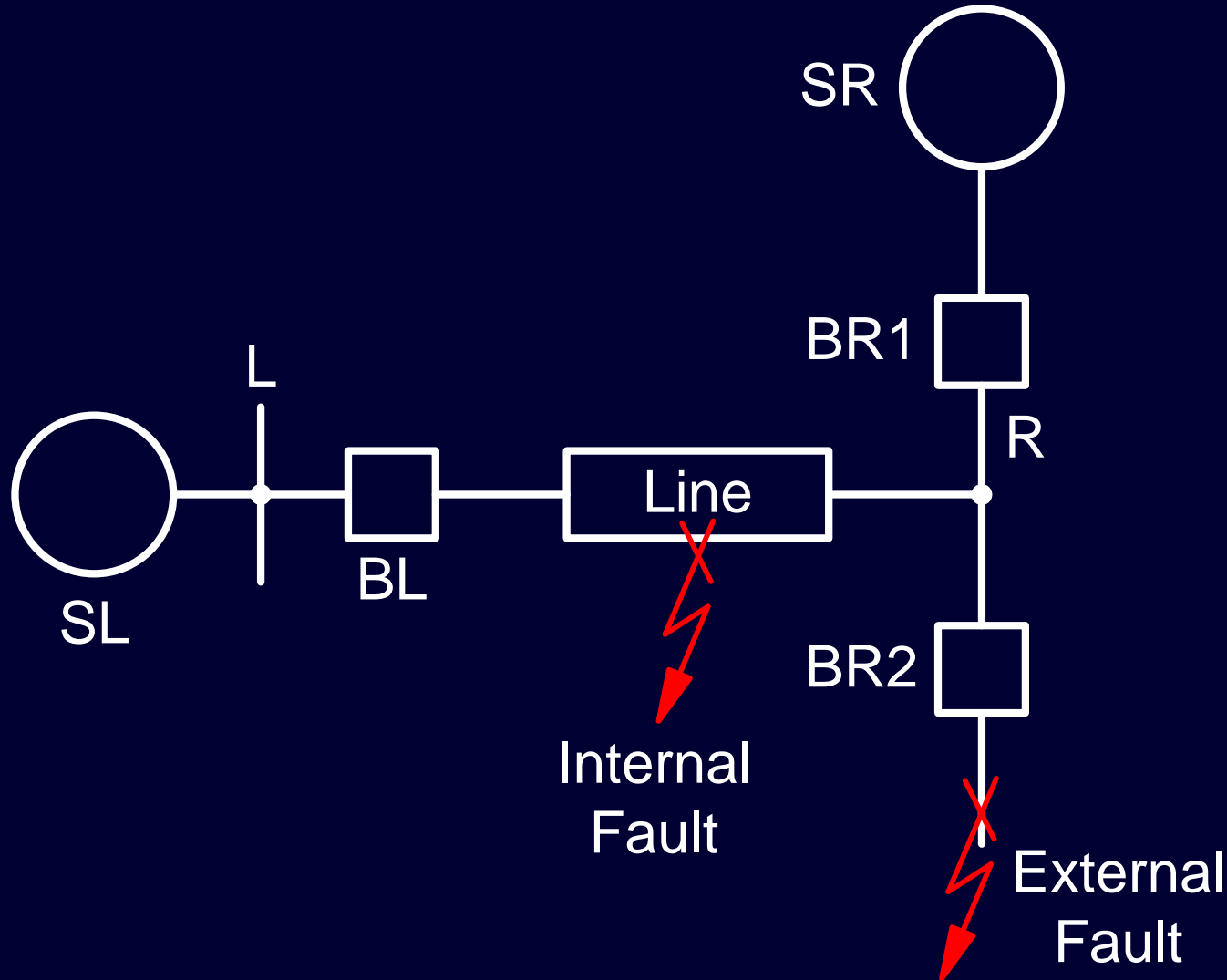
# Effect of Remanence on CT Performance



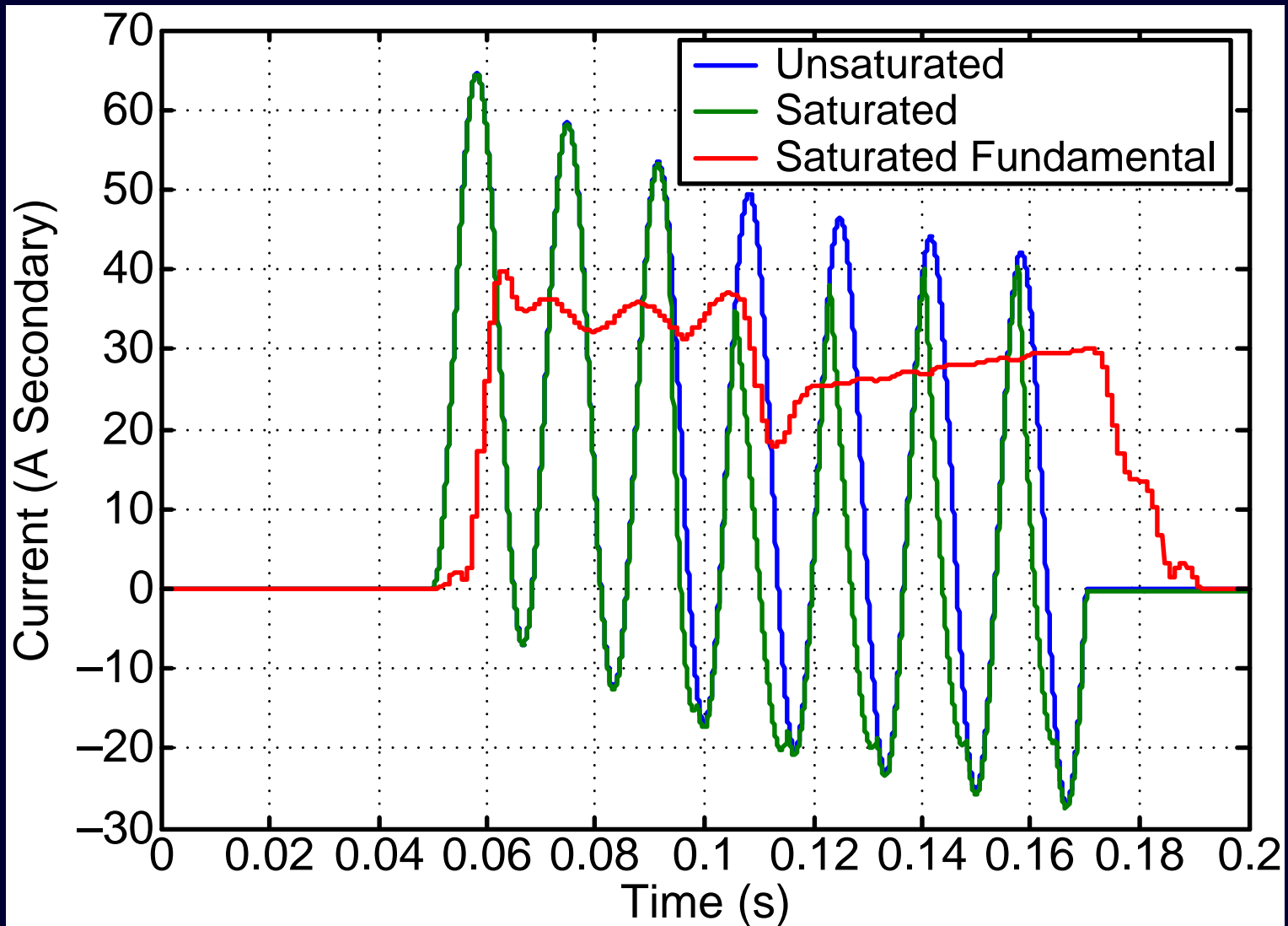
$$\frac{I_f Z_b \left( \frac{X}{R} + 1 \right)}{1 - \text{remanence (pu)}} \leq 20$$

# **Effects of CT Saturation on Protection Elements**

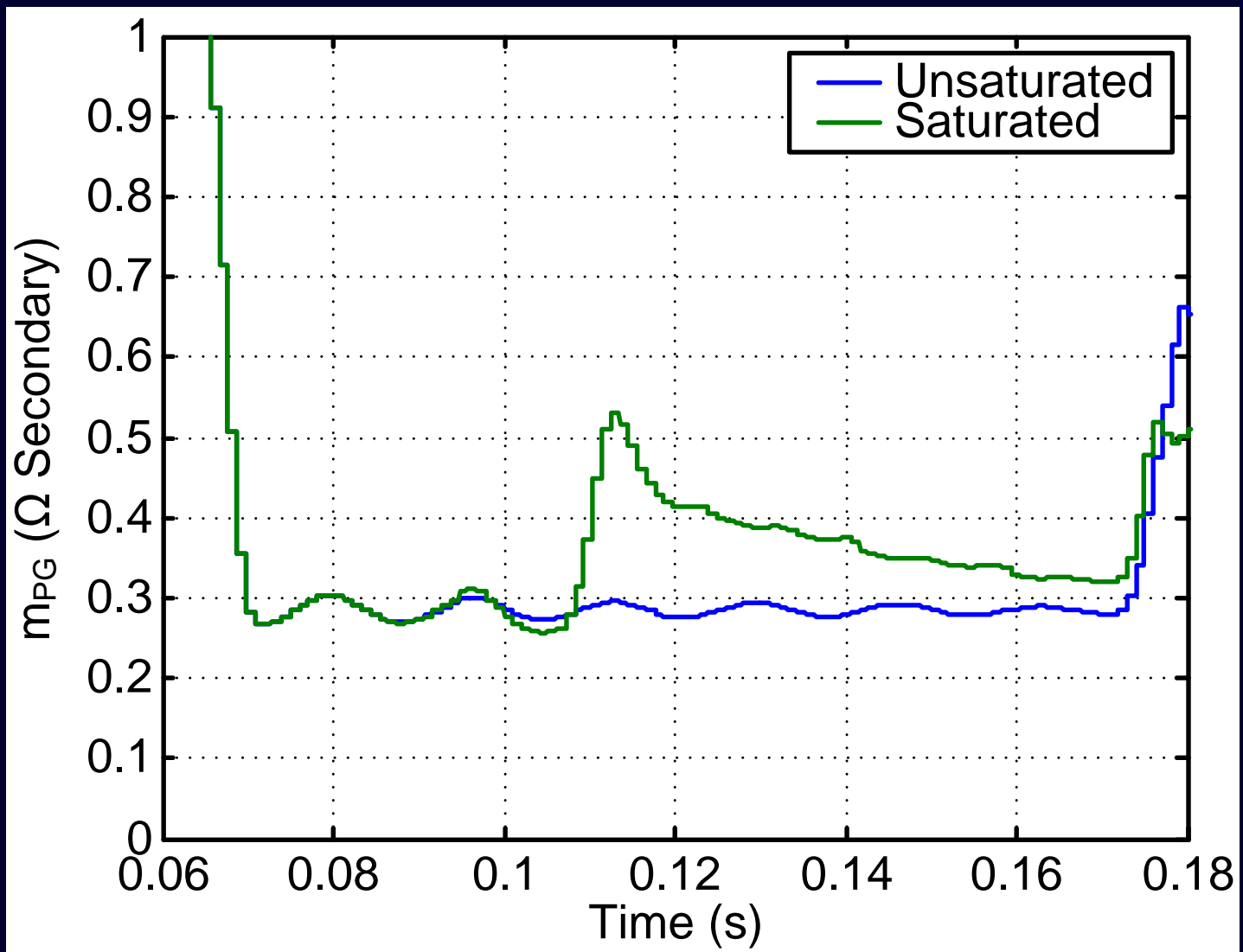
# Example Power System



# CT Saturation Affects Overcurrent Element Measurements

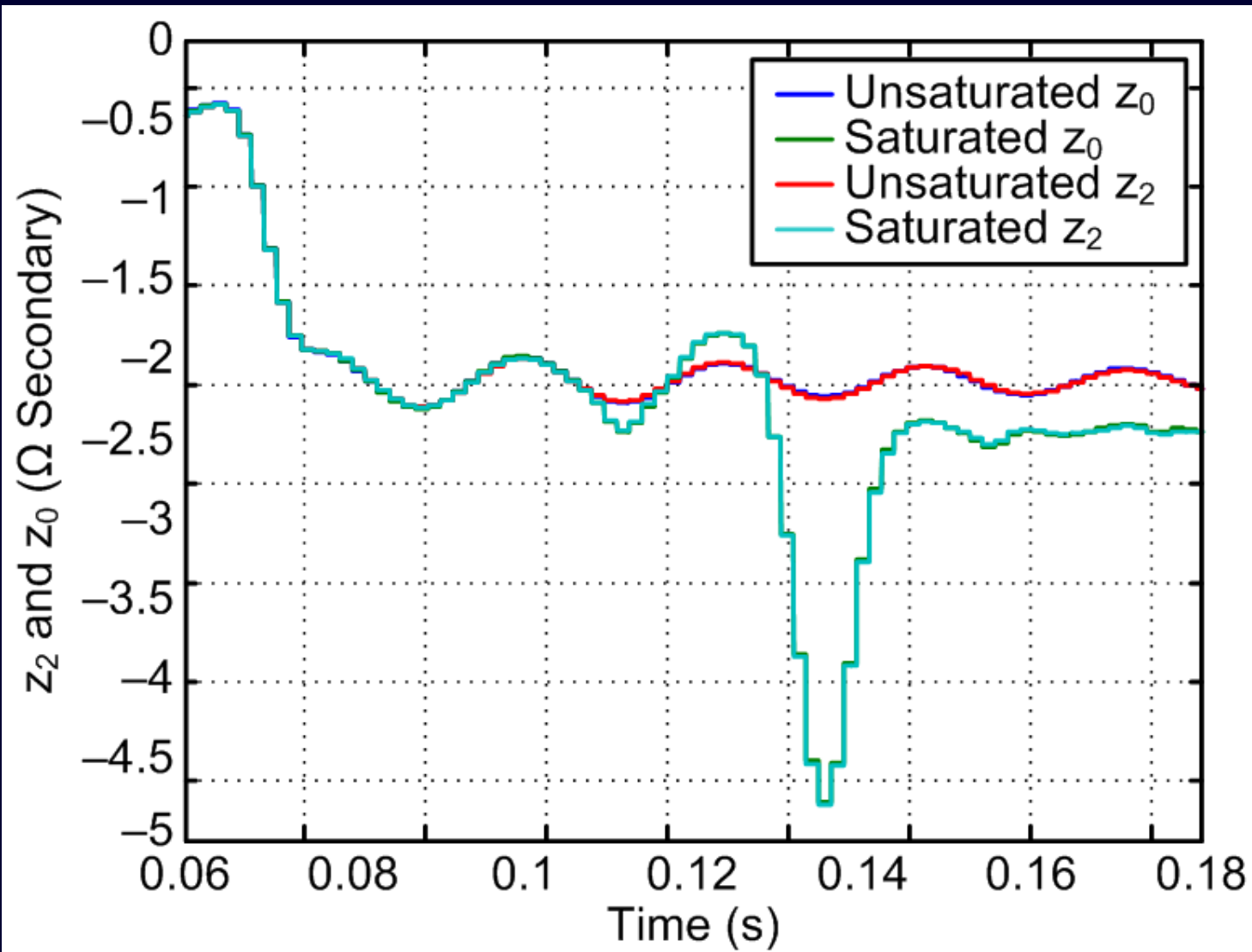


# CT Saturation Causes Distance Element Underreach

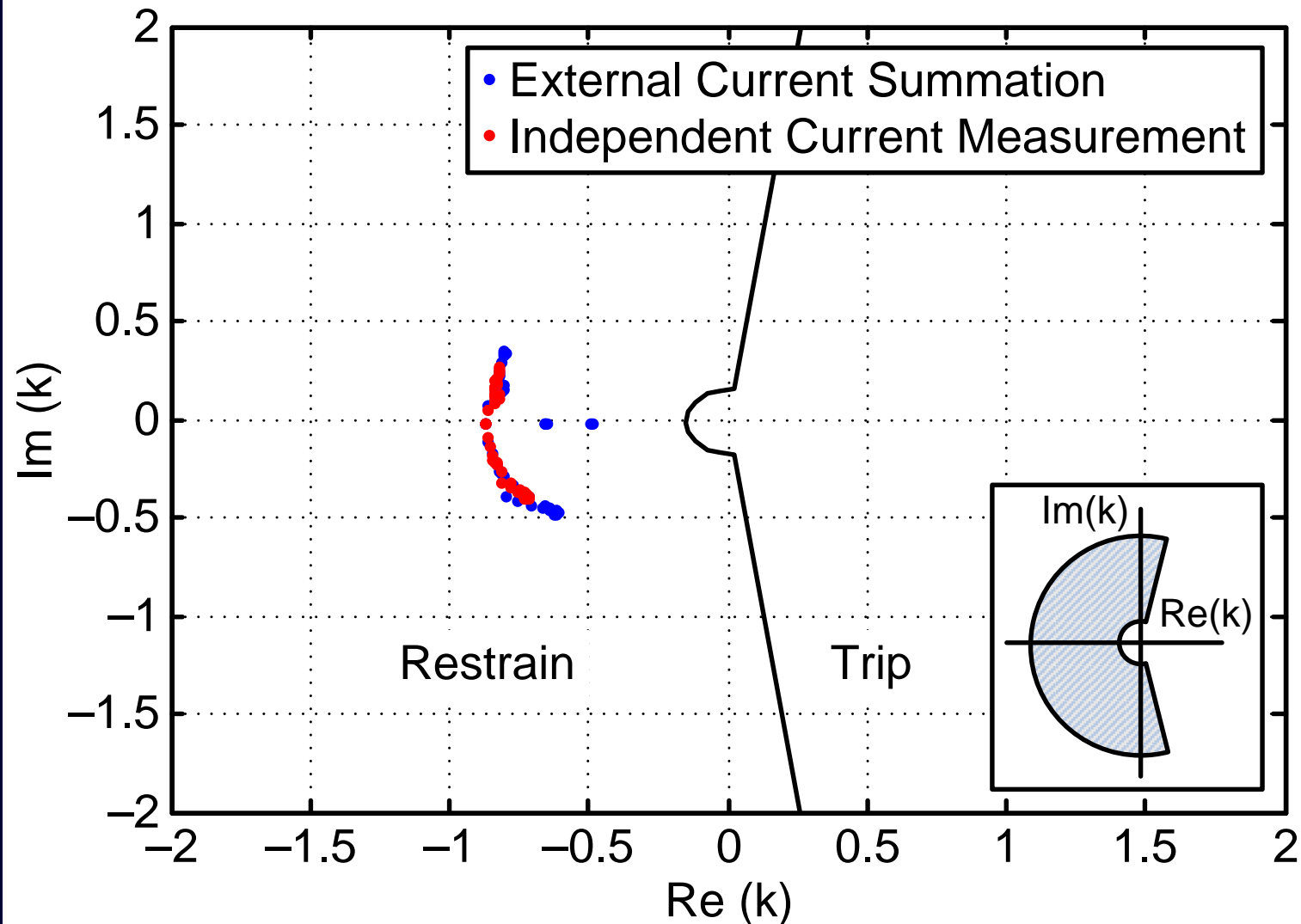




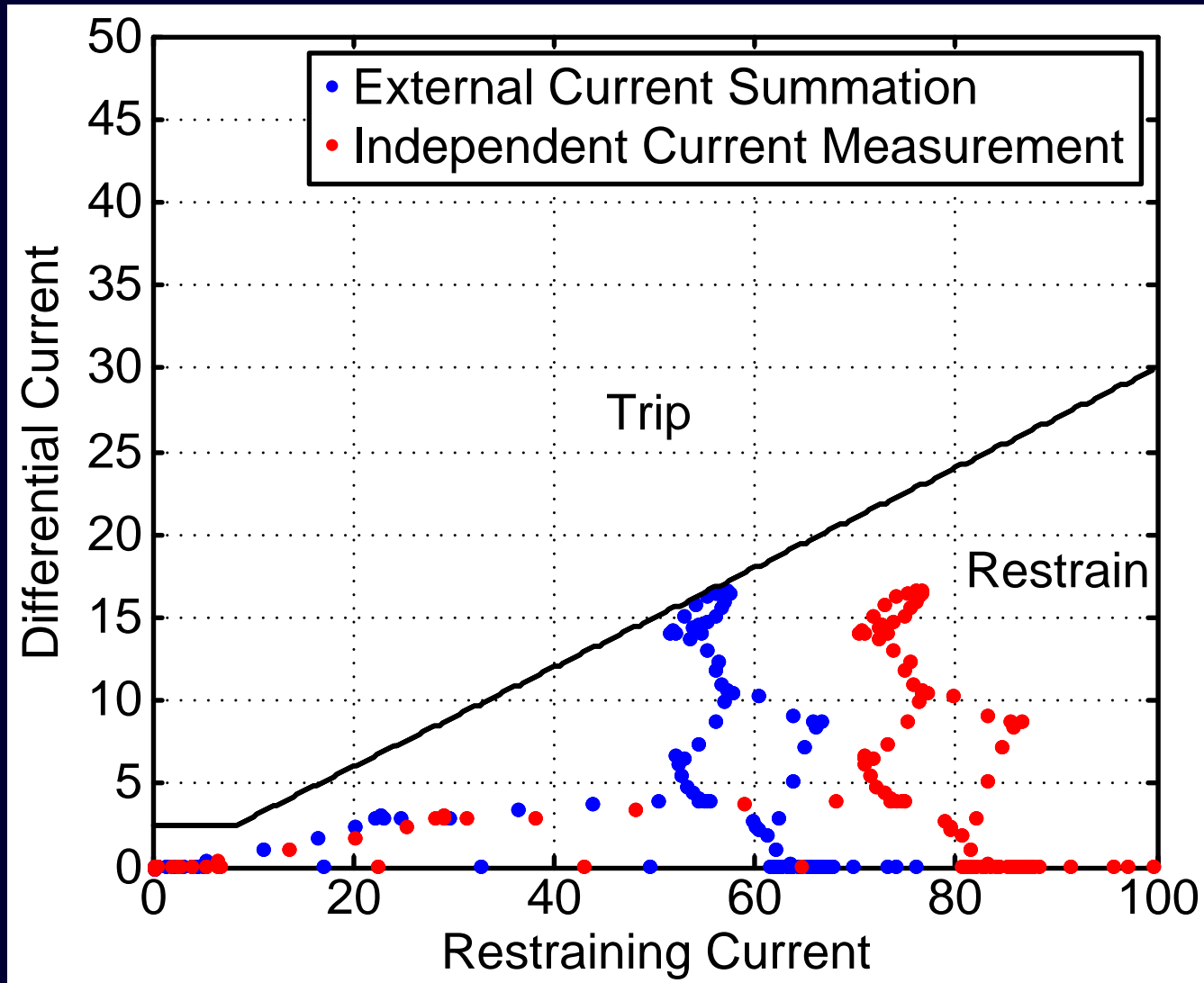
# Directional Element Response for Internal Fault



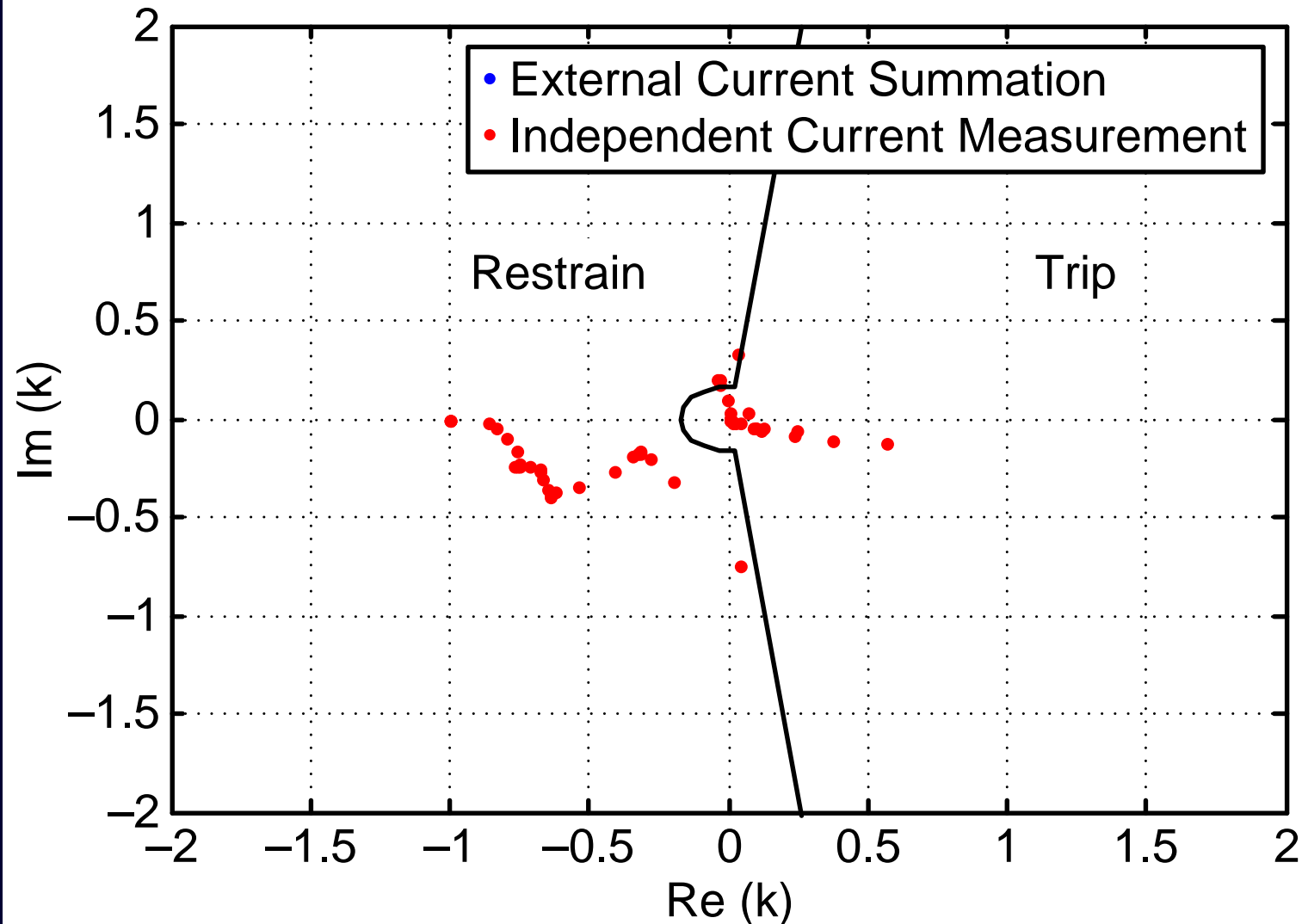
# Alpha Plane Phase Plot for External Fault



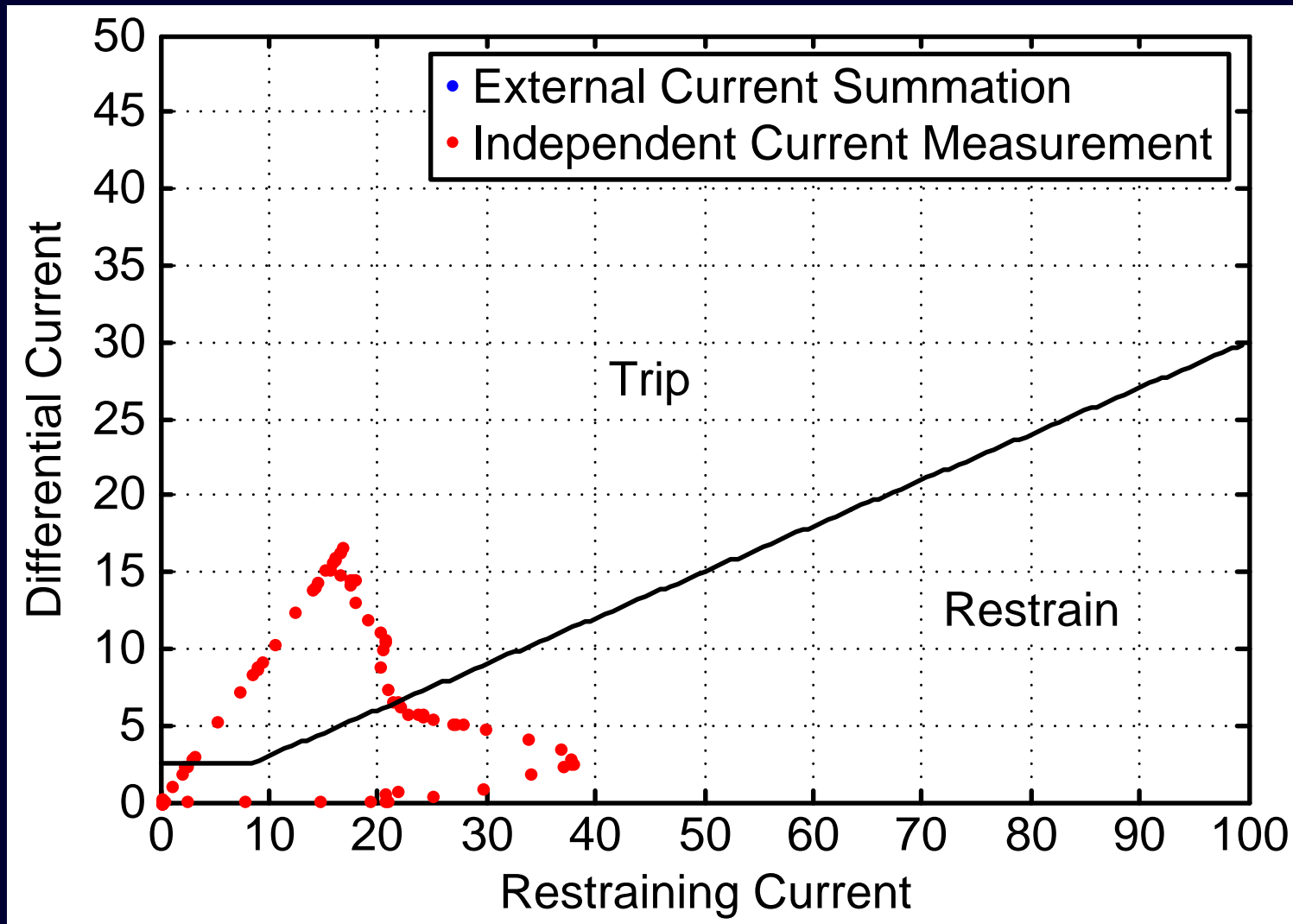
# Percentage Differential Phase Plot for External Fault



# Zero-Sequence Alpha Plane Plot for External Fault



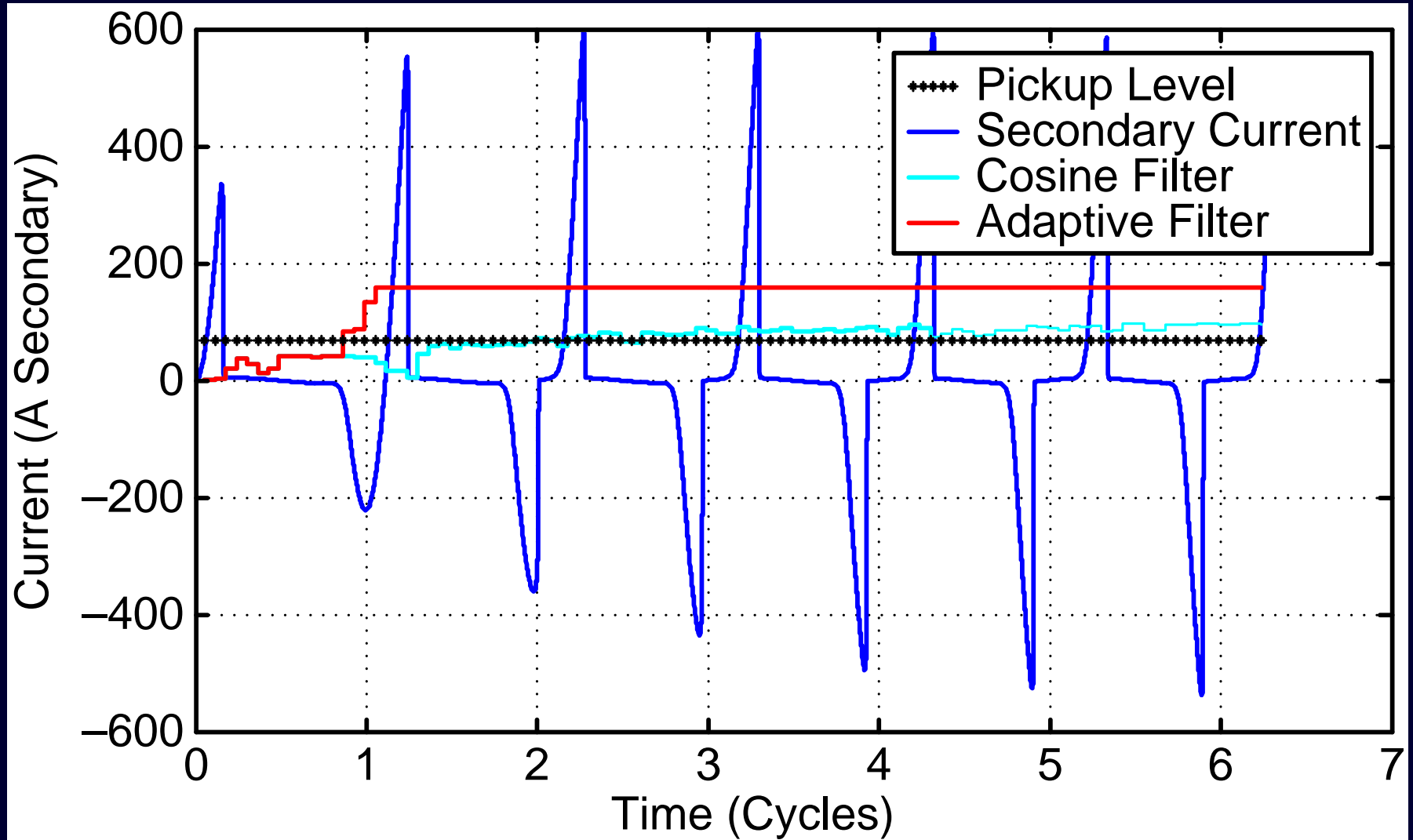
# Zero-Sequence Percentage Differential Plot for External Fault



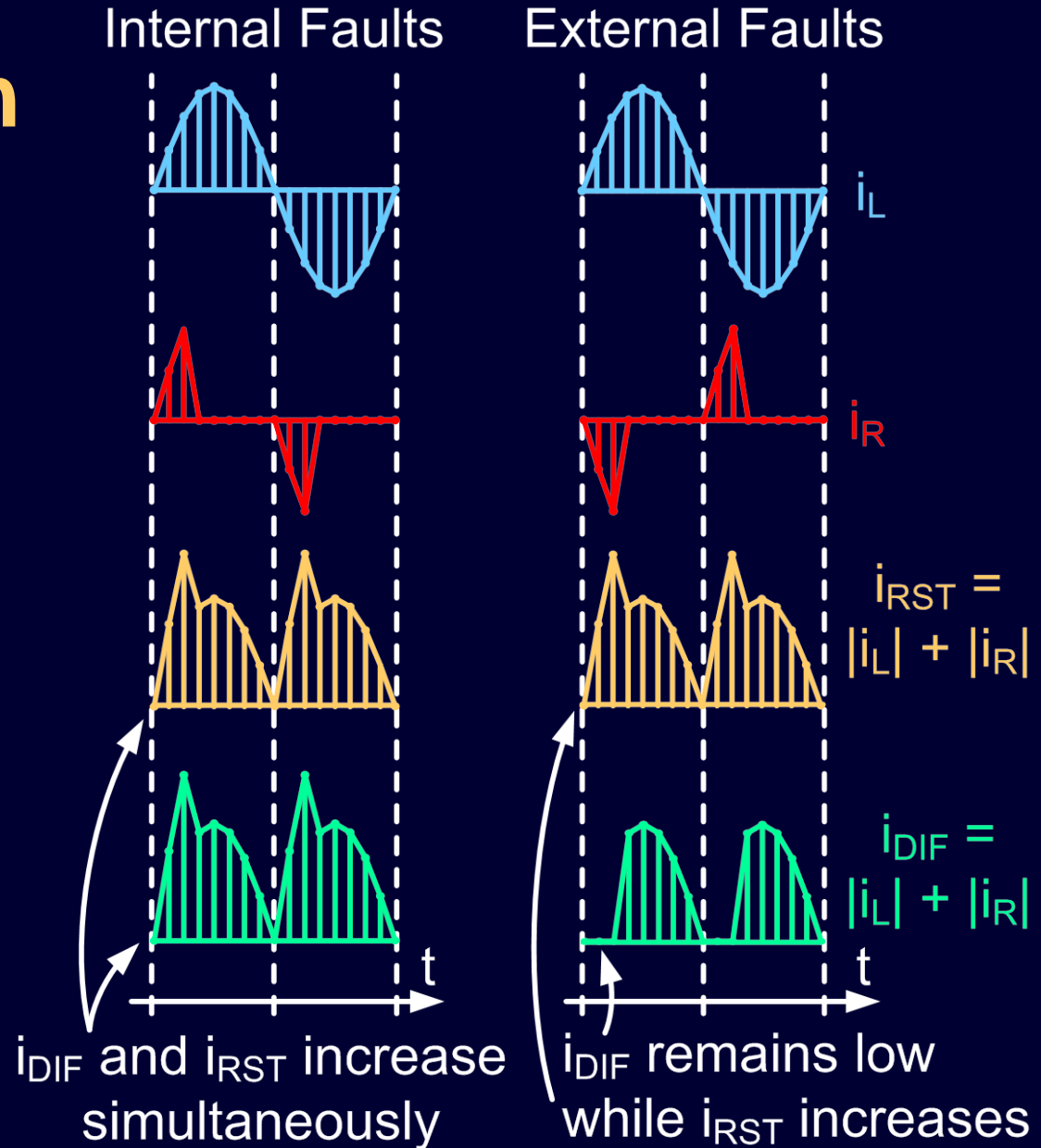
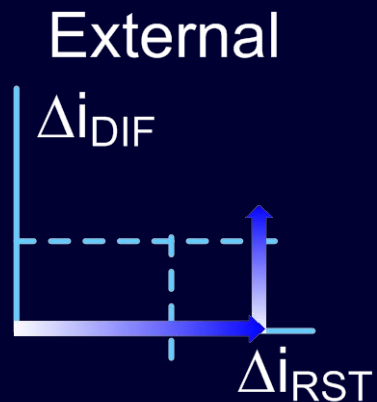
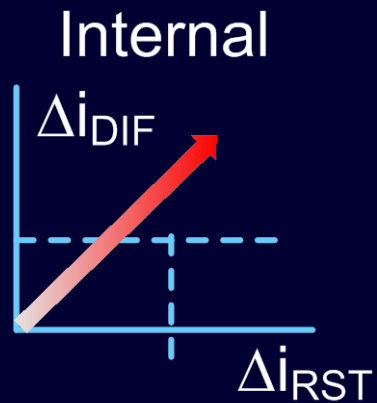
# Advances in Modern Protection Designs

- High-speed distance elements
- Cosine-peak adaptive filter for overcurrent elements
- External fault detection for differential elements

# Adaptive Filter Performance

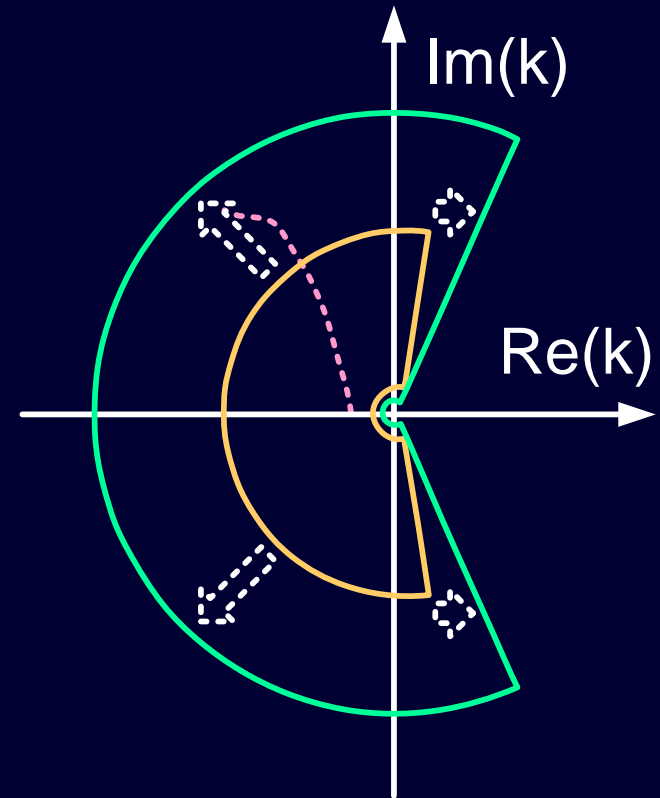
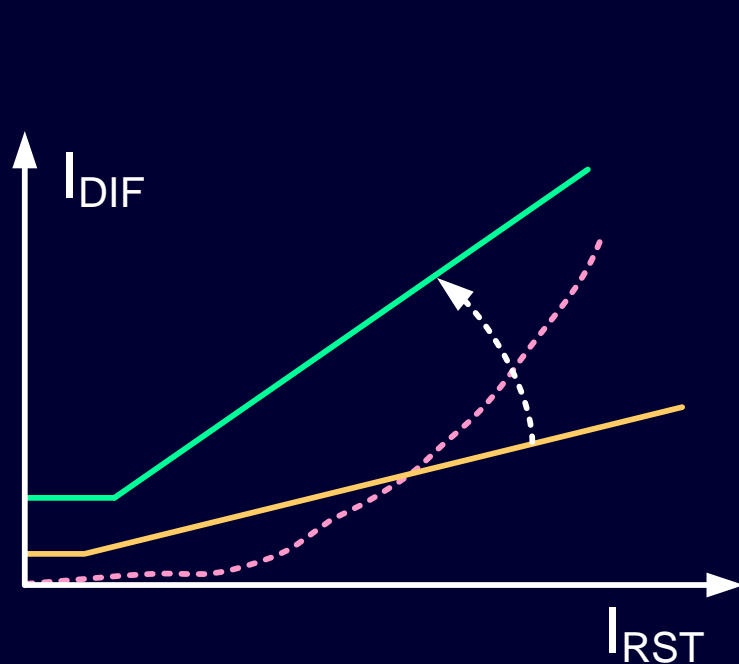


# External Fault Detection Principle





# Adaptive Differential Characteristics



- Normal Security
- - - CT Errors
- Extended Security

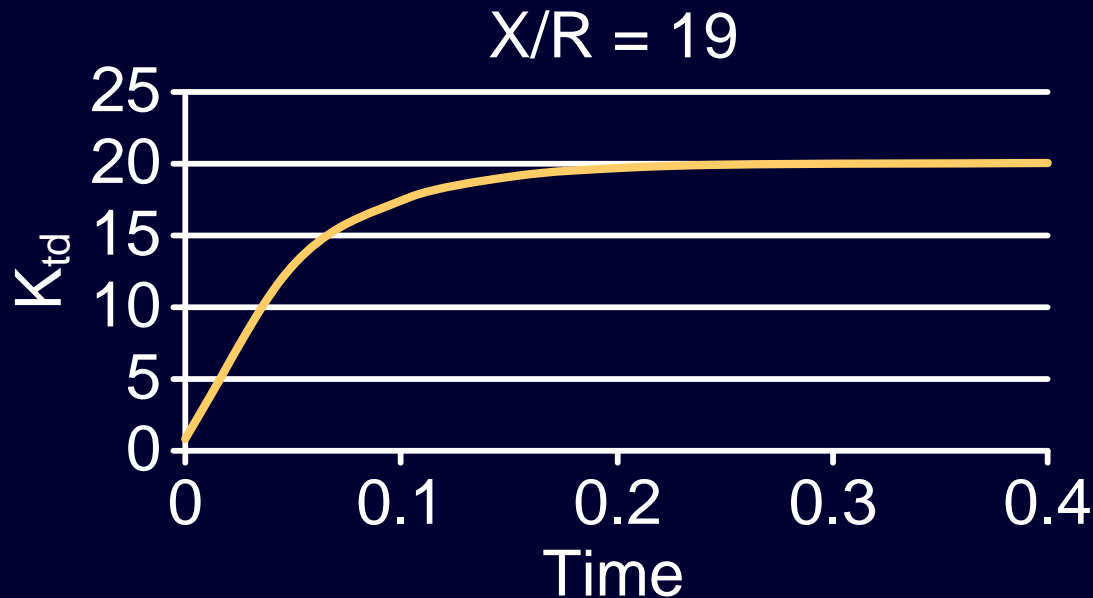
# Tools for CT Sizing

# Checks for Saturation-Free Operation

- Example: C400, 2000/5 CT with  $1\ \Omega$  burden and 30% remanence
  - ♦  $Z_b = 1\ \Omega$
  - ♦  $Z_{B\ STD} = 4\ \Omega$
- Maximum asymmetrical fault current for  $X/R = 12$ :  $I_{f\ max} = 6.15 (1 - 0.3) = 4.3\ pu = 8.6\ kA$

# IEC Guidelines

$$E_{al} = K_{ssc} K_{td} (R_{ct} + R_b) I_{sn} \quad K_{td} = \frac{\omega T_P T_S}{T_P - T_S} \left( e^{-t/T_P} - e^{-t/T_S} \right) + 1$$



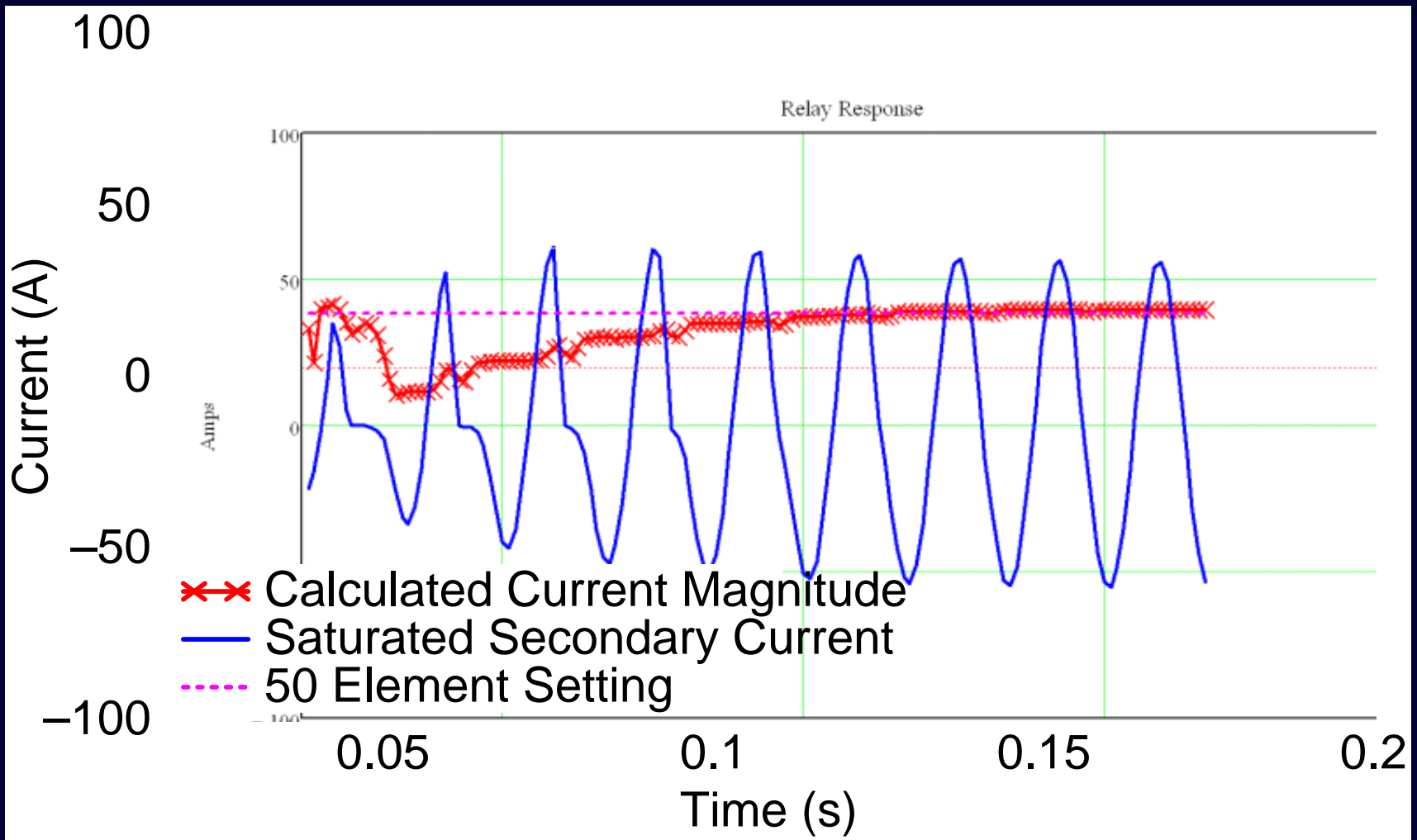
Faster operating time results in  
lower transient dimensioning factor

# Manufacturer Guidance

$$R_{bmax} = \frac{kV_s}{I_f \left( \frac{X}{R} + 1 \right)}$$

Relay	$k$	Criteria
Distance	6	No dropout of Zone 2 with reach of 125%
Differential	7.5	Secure operation during external faults

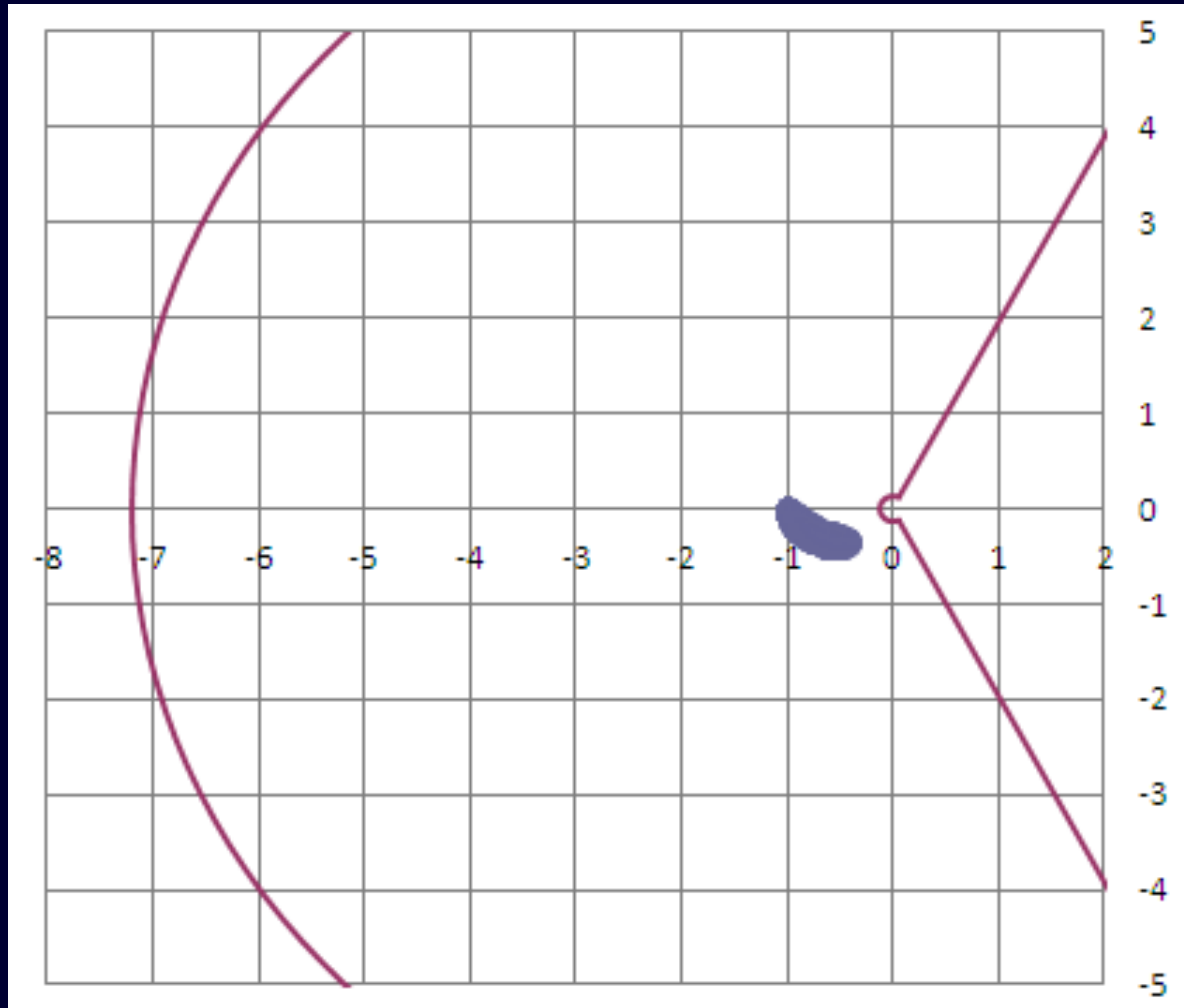
# CT Modeling – Mathcad®



Evaluate impact on settings and speed

# CT Modeling – PSRC Spreadsheet

## Relay Model Linked to Spreadsheet



# Conclusion

- CT saturation is sometimes unavoidable
- CT saturation affects relay security, speed, and sensitivity
- Modern relays include algorithms to deal with CT saturation
- Manufacturers provide guidelines that simplify CT selection
- Tools are available to protection engineers



**Questions?**

